BFU630F

NPN wideband silicon RF transistor

Rev. 1 — 15 December 2010

Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

1.2 Features and benefits

- Low noise high gain microwave transistor
- Noise figure (NF) = 0.85 dB at 2.4 GHz
- High maximum stable gain 26 dB at 1.8 GHz
- 40 GHz f_T silicon technology

1.3 Applications

- Low noise amplifiers for microwave communications systems
- WLAN and CDMA applications
- Analog/digital cordless applications
- Ku band oscillators DRO's
- LNB
- RKE
- AMR
- GPS
- ZigBee
- LTE, cellular, UMTS
- FM radio
- Mobile TV
- Bluetooth



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1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-	16	V
V_{CEO}	collector-emitter voltage	open base	-	-	5.5	V
V_{EBO}	emitter-base voltage	open collector	-	-	2.5	V
I _C	collector current		-	3	30	mA
P_{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	[1] -	-	200	mW
h _{FE}	DC current gain	$I_C = 5 \text{ mA}; V_{CE} = 2 \text{ V};$ $T_j = 25 \text{ °C}$	90	135	180	
C _{CBS}	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	47	-	fF
f _T	transition frequency	I_C = 10 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	-	21	-	GHz
G _{p(max)}	maximum power gain	I_C = 15 mA; V_{CE} = 2 V; f = 2.4 GHz; T_{amb} = 25 °C	[2] -	24.5	-	dB
NF	noise figure	I_C = 3 mA; V_{CE} = 2 V; f = 2.4 GHz; Γ_S = Γ_{opt}	-	0.85	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	I_C = 30 mA; V_{CE} = 2.5 V; Z_S = Z_L = 50 Ω ; f = 2.4 GHz; T_{amb} = 25 °C	-	11.5	-	dBm

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2 —
4	collector		.)
		2 1	1, 3 mbb159
		2 1	11100 139

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BFU630F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F		

 $[\]label{eq:Gpmax} \begin{tabular}{ll} [2] & $G_{p(max)}$ is the maximum power gain, if $K>1$. If $K<1$ then $G_{p(max)}=Maximum Stable Gain (MSG). \end{tabular}$

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4. Marking

Table 4. Marking

<u> </u>		
Type number	Marking	Description
BFU630F	D2*	* = p: made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

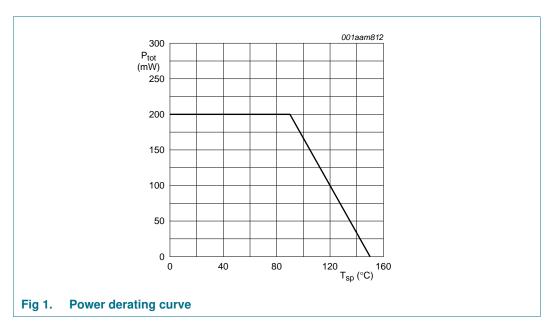
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	16	V
V_{CEO}	collector-emitter voltage	open base	-	5.5	V
V_{EBO}	emitter-base voltage	open collector	-	2.5	V
I _C	collector current		-	30	mA
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	<u>[1]</u> -	200	mW
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C
•					

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point		300	K/W



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7. Characteristics

Table 7. Characteristics

 $T_i = 25$ °C unless otherwise specified

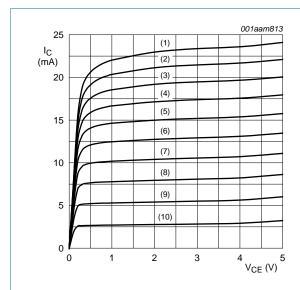
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 mA$	16	-	-	V
V _{(BR)CEO}	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}; I_B = 0 \text{ mA}$	5.5	-	-	٧
lc	collector current		-	3	30	mΑ
I _{CBO}	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	-	100	nΑ
h _{FE}	DC current gain	$I_C = 5 \text{ mA}; V_{CE} = 2 \text{ V}$	90	135	180	
C _{CES}	collector-emitter capacitance	V _{CB} = 2 V; f = 1 MHz	-	264	-	fF
C _{EBS}	emitter-base capacitance	V _{EB} = 0.5 V; f = 1 MHz	-	332	-	fF
C _{CBS}	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	47	-	fF
f _T	transition frequency	I_C = 10 mA; V_{CE} = 2 V; f = 2 GHz; T_{amb} = 25 °C	-	21	-	GH
G _{p(max)}	maximum power gain	$I_C = 15 \text{ mA}; V_{CE} = 2 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	[1]			
•		f = 1.5 GHz	-	27	-	dB
		f = 1.8 GHz	-	26	180	dB
		f = 2.4 GHz	-	24.5	-	dB
		f = 5.8 GHz	-	16	-	dB
s ₂₁ ²	insertion power gain	$I_C = 15 \text{ mA}; V_{CE} = 2 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$				
		f = 1.5 GHz	-	22.5	-	dB
		f = 1.8 GHz	-	21	-	dB
		f = 2.4 GHz	-	19	-	dB
		f = 5.8 GHz	-	12	-	dB
NF	noise figure	I_C = 3 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	0.75	-	dB
		f = 1.8 GHz	-	0.80	-	dB
		f = 2.4 GHz	-	0.85	-	dB
		f = 5.8 GHz	-	1.30	-	dB
G _{ass}	associated gain	I_C = 3 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	22.5	-	dB
		f = 1.8 GHz	-	21	-	dB
		f = 2.4 GHz	-	19	-	dB
		f = 5.8 GHz	-	13	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	I_{C} = 30 mA; V_{CE} = 2.5 V; Z_{S} = Z_{L} = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	12.5	-	dBr
		f = 1.8 GHz	-	12.5	-	dBr
		f = 2.4 GHz	-	11.5	-	dBr
		f = 5.8 GHz	-	12.5	-	dBr

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Table 7. Characteristics ... continued $T_i = 25$ °C unless otherwise specified

,	•					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
IP3 third-order intercept point		$I_C = 30 \text{ mA}; V_{CE} = 2.5 \text{ V};$ $Z_S = Z_L = 50 \Omega; T_{amb} = 25 \text{ °C}$				
		f = 1.5 GHz	-	25.5	-	dBm
		f = 1.8 GHz	-	26	-	dBm
		f = 2.4 GHz	-	26.5	-	dBm
		f = 5.8 GHz	-	27.5	-	dBm

[1] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.



 $T_{amb} = 25 \, ^{\circ}C.$

(1) $I_B = 200 \mu A$

(2) $I_B = 180 \mu A$

(3) $I_B = 160 \mu A$

(4) $I_B = 140 \,\mu\text{A}$

(4) $I_B = 140 \, \mu A$

(5) $I_B = 120 \mu A$ (6) $I_B = 100 \mu A$

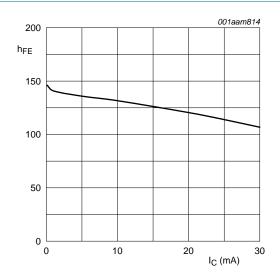
(7) $I_B = 80 \mu A$

(8) $I_B = 60 \mu A$

(9) $I_B = 40 \mu A$

(10) $I_B = 20 \mu A$

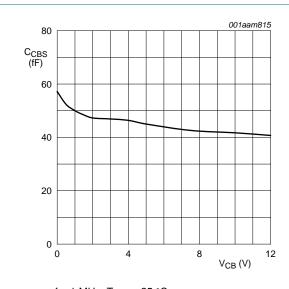
Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $V_{CE} = 2 \text{ V}$; $T_{amb} = 25 \, ^{\circ}\text{C}$.

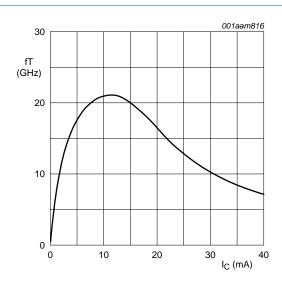
Fig 3. DC current gain as a function of collector current; typical values

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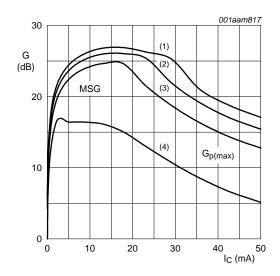
 $f = 1 \text{ MHz}, T_{amb} = 25 \,^{\circ}\text{C}.$

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 2 \text{ V}$; f = 2 GHz; $T_{amb} = 25 \,^{\circ}\text{C}$.

Fig 5. Transition frequency as a function of collector current; typical values

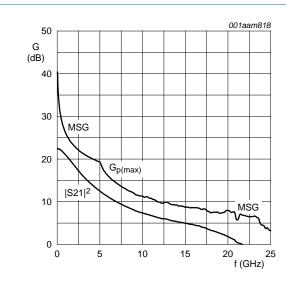


 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 1.5 GHz
- (2) f = 1.8 GHz
- (3) f = 2.4 GHz
- (4) f = 5.8 GHz

Fig 6. Gain as a function of collector current; typical value

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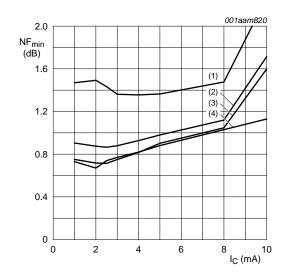
 $V_{CE} = 2 \text{ V}; I_C = 5 \text{ mA}; T_{amb} = 25 \text{ °C}.$

G (dB) 40 MSG 30 MSG 30 MSG 10 15 20 25 f (GHz)

 V_{CE} = 2 V; I_{C} = 15 mA; T_{amb} = 25 °C.

Fig 7. Gain as a function of frequency; typical values

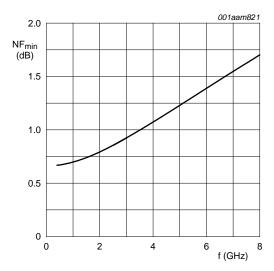




 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 5.8 GHz
- (2) f = 2.4 GHz
- (3) f = 1.8 GHz
- (4) f = 1.5 GHz

Fig 9. Minimum noise figure as a function of collector current; typical values



 V_{CE} = 2 V; I_{C} = 3 mA; T_{amb} = 25 °C.

Fig 10. Minimum noise figure as a function of frequency; typical values

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8. Package outline

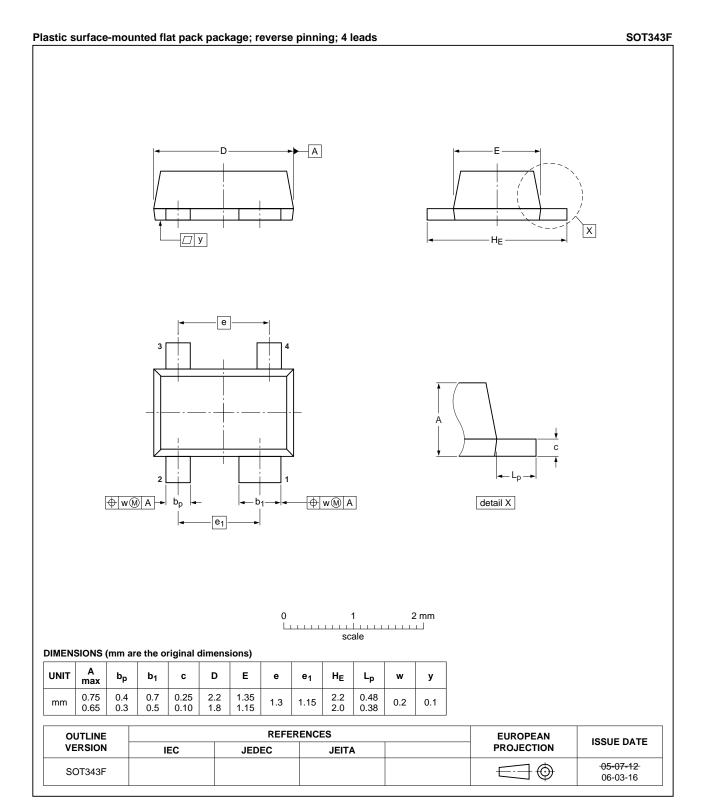


Fig 11. Package outline SOT343F

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9. Abbreviations

Table 8. Abbreviations

Acronym	Description
AMR	Automatic Meter Reading
CDMA	Code Division Multiple Access
DC	Direct Current
DRO	Dielectric Resonator Oscillator
FM	Frequency Modulation
GPS	Global Positioning System
LNA	Low Noise Amplifier
LNB	Low Noise Block
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
RF	Radio Frequency
RKE	Remote Keyless Entry
UMTS	Universal Mobile Telecommunications System
WLAN	Wireless Local Area Network

10. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU630F v.1	20101215	Product data sheet	-	-

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11. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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